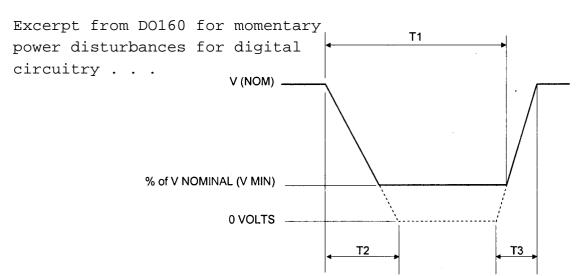
Table 16-3 Test Conditions for DC Equipment with Digital Circuits



Notes:

- 1. Definitions:
  - T1 Power interrupt time.
  - T2 Time it would take for the applied voltage to decay from V (nom) to zero volts.
  - T3 Time it would take for the applied voltage to rise from zero to V (nom) volts.

V MIN The minimum level (expressed as a percentage of V NOMINAL) to which the applied voltage is permitted to decay.

2. Tolerance to T1, T2,  $T3 = \pm 10\%$ .

Applicable Category	A, B, Z				A, Z			Z	A, B, Z		A, Z				Z	A, B, Z			
Test Condition No.	1	2*	3	4	5	6	7	8	9*	10*	11	12	13	14	15	16*	17*	18*	19
T1 (mS)	2	10	25	50	75	100	200	1000	10	25	50	75	100	200	1000	30	35	40	25
T2 (mS)	<1	20*	20	20	20	20	20	20	50*	50*	50	50	50	50	50	50*	50*	20*	5
T3 (mS)	<1	5	5	5	5	5	5	5	20	20	20	20	20	20	20	20	5	20	5
% of Vnominal (V min)	0	50	15	10	5	0	0	0	80	50	0	15	5	0	0	65	60	35	0

<sup>\*</sup> Voltage will not reach zero in this test condition.